

74VHC14 Hex Schmitt Inverter

General Description

The VHC14 is an advanced high speed CMOS Hex Schmitt Inverter fabricated with silicon gate CMOS technology. It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation. Pin configuration and function are the same as the VHC04 but the inputs have hysteresis between the positive-going and negative-going input thresholds, which are capable of transforming slowly changing input signals into sharply defined, jitter-free output signals, thus providing greater noise margin than conventional inverters.

An input protection circuit ensures that 0V to 7V can be applied to the input pins without regard to the supply volt-

age. This device can be used to interface 5V to 3V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

Features

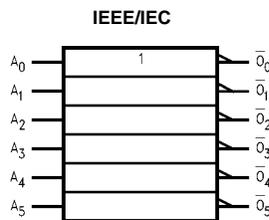
- High Speed: $t_{PD} = 5.5$ ns (typ) at $V_{CC} = 5V$
- Low power dissipation: $I_{CC} = 2$ μA (Max) at $T_A = 25^\circ C$
- High noise immunity: $V_{NIH} = V_{NIL} = 28\%$ V_{CC} (Min)
- Power down protection is provided on all inputs
- Low noise: $V_{OLP} = 0.8V$ (Max)
- Pin and function compatible with 74HC14

Ordering Code:

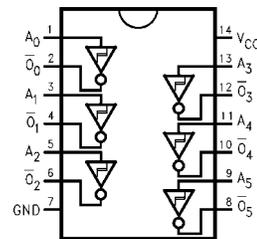
Order Number	Package Number	Package Description
74VHC14M	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow
74VHC14SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74VHC14MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74VHC14N	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Surface mount packages are also available on Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



Pin Descriptions

Pin Names	Description
A_n	Inputs
\bar{O}_n	Outputs

Truth Table

A	O
L	H
H	L

Absolute Maximum Ratings (Note 1)

Supply Voltage (V_{CC})	-0.5V to +7.0V
DC Input Voltage (V_{IN})	-0.5V to +7.0V
DC Output Voltage (V_{OUT})	-0.5V to $V_{CC} + 0.5V$
Input Diode Current (I_{IK})	-20 mA
Output Diode Current (I_{OK})	± 20 mA
DC Output Current (I_{OUT})	± 25 mA
DC V_{CC} /GND Current (I_{CC})	± 50 mA
Storage Temperature (T_{STG})	-65°C to +150°C
Lead Temperature (T_L)	
Soldering (10 seconds)	260°C

Recommended Operating Conditions (Note 2)

Supply Voltage (V_{CC})	+2.0V to +5.5V
Input Voltage (V_{IN})	0V to +5.5V
Output Voltage (V_{OUT})	0V to V_{CC}
Operating Temperature (T_{OPR})	-40°C to +85°C

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. The data book specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation outside databook specifications.

Note 2: Unused inputs must be held HIGH or LOW. They may not float.

DC Electrical Characteristics

Symbol	Parameter	V_{CC}	$T_A = 25^\circ\text{C}$			$T_A = -40^\circ\text{C to } +85^\circ\text{C}$		Units	Conditions
			Min	Typ	Max	Min	Max		
V_P	Positive Threshold Voltage	3.0			2.20		2.20	V	
		4.5			3.15		3.15		
		5.5			3.85		3.85		
V_N	Negative Threshold Voltage	3.0	0.90			0.90		V	
		4.5	1.35			1.35			
		5.5	1.65			1.65			
V_H	Hysteresis Voltage	3.0	0.30		1.20	0.30	1.20	V	
		4.5	0.40		1.40	0.40	1.40		
		5.5	0.50		1.60	0.50	1.60		
V_{OH}	HIGH Level Output Voltage	2.0	1.9	2.0		1.9		V	$V_{IN} = V_{IL}$ $I_{OH} = -50 \mu\text{A}$
		3.0	2.9	3.0		2.9			
		4.5	4.4	4.5		4.4			
		3.0	2.58			2.48			
4.5	3.94			3.80					
V_{OL}	LOW Level Output Voltage	2.0		0.0	0.1		0.1	V	$V_{IN} = V_{IH}$ $I_{OL} = 50 \mu\text{A}$
		3.0		0.0	0.1		0.1		
		4.5		0.0	0.1		0.1		
		3.0			0.36		0.44		
4.5			0.36		0.44				
I_{IN}	Input Leakage Current	0-5.5			± 0.1		± 1.0	μA	$V_{IN} = 5.5V$ or GND
I_{CC}	Quiescent Supply Current	5.5			2.0		20.0	μA	$V_{IN} = V_{CC}$ or GND

Noise Characteristics

Symbol	Parameter	V_{CC}	$T_A = 25^\circ\text{C}$		Units	Conditions
			Typ	Limits		
V_{OLP} (Note 3)	Quiet Output Maximum Dynamic V_{OL}	5.0	0.4	0.8	V	$C_L = 50 \text{ pF}$
V_{OLV} (Note 3)	Quiet Output Minimum Dynamic V_{OL}	5.0	-0.4	-0.8	V	$C_L = 50 \text{ pF}$
V_{IHD} (Note 3)	Minimum HIGH Level Dynamic Input Voltage	5.0		3.5	V	$C_L = 50 \text{ pF}$
V_{ILD} (Note 3)	Maximum LOW Level Dynamic Input Voltage	5.0		1.5	V	$C_L = 50 \text{ pF}$

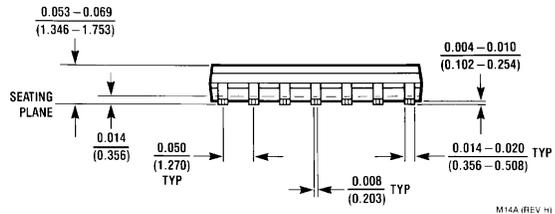
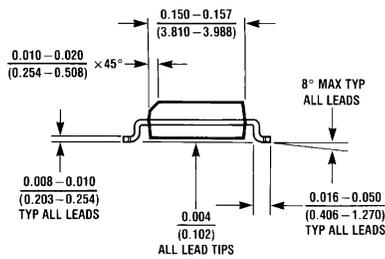
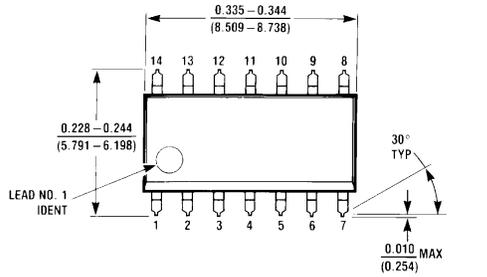
Note 3: Parameter guaranteed by design.

AC Electrical Characteristics

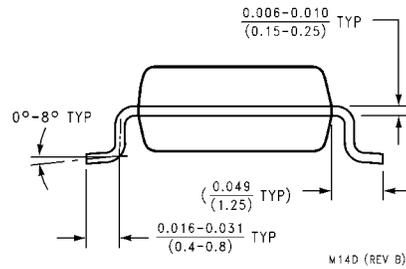
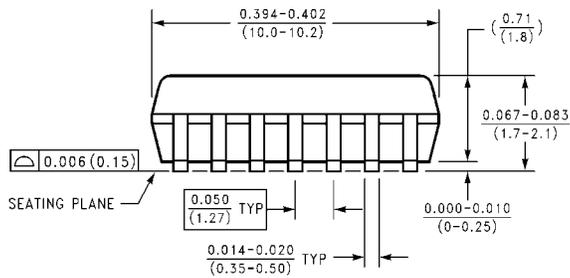
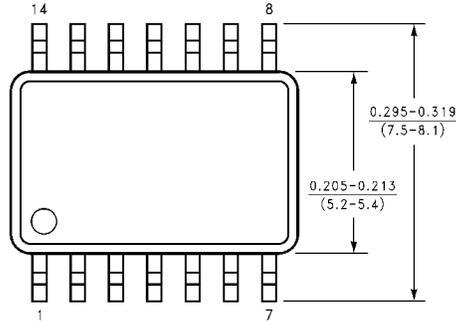
Symbol	Parameter	V _{CC}	T _A = 25°C			T _A = -40°C to +85°C		Units	Conditions
			Min	Typ	Max	Min	Max		
t _{PLH}	Propagation Delay Time	3.3 ± 0.3	8.3	12.8	1.0	15.0	ns	C _L = 15 pF	
t _{PHL}			10.8	16.3	1.0	18.5		C _L = 50 pF	
		5.0 ± 0.5	5.5	8.6	1.0	10.0	ns	C _L = 15 pF	
			7.0	10.6	1.0	12.0		C _L = 50 pF	
C _{IN}	Input Capacitance		4	10		10	pF	V _{CC} = Open	
C _{PD}	Power Dissipation Capacitance		21				pF	(Note 4)	

Note 4: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation: I_{CC (Opr)} = C_{PD} * V_{CC} * f_{IN} + I_{CC}/6 (per Gate)

Physical Dimensions inches (millimeters) unless otherwise noted

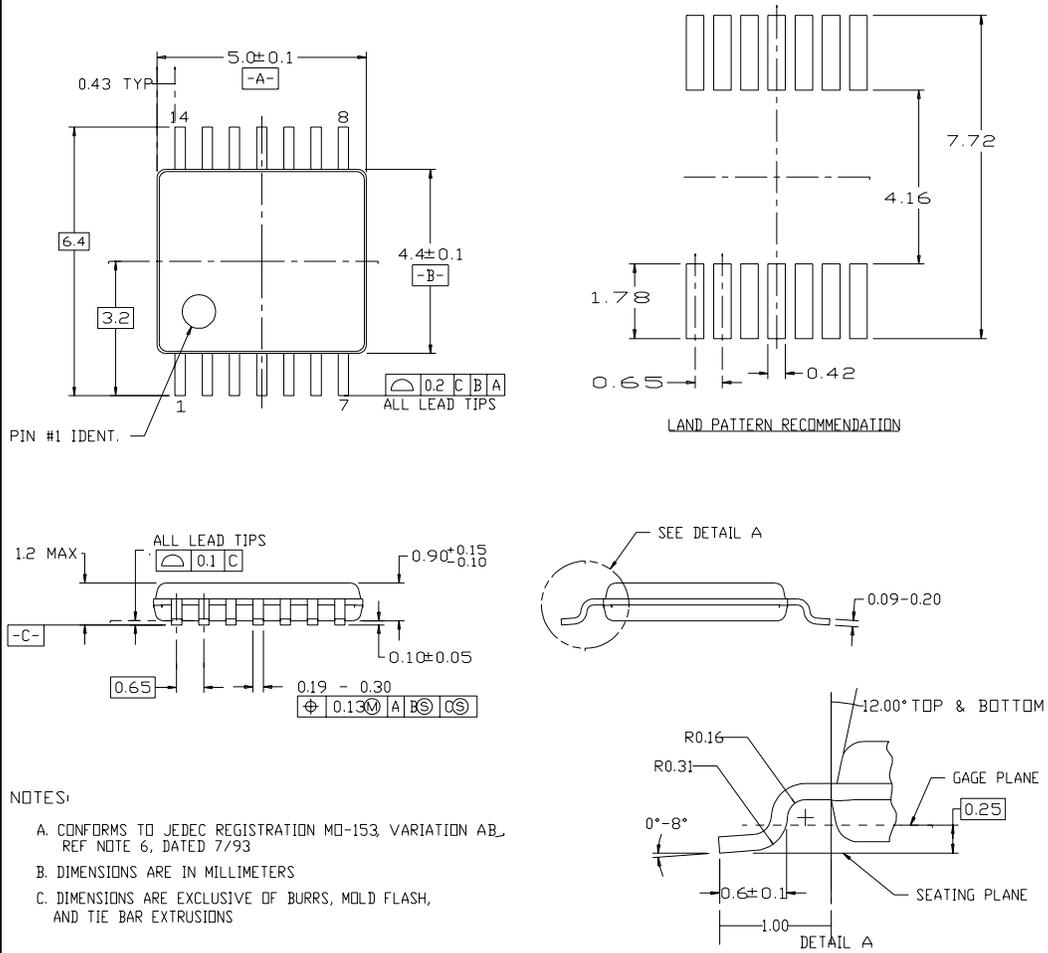


**14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow
Package Number M14A**



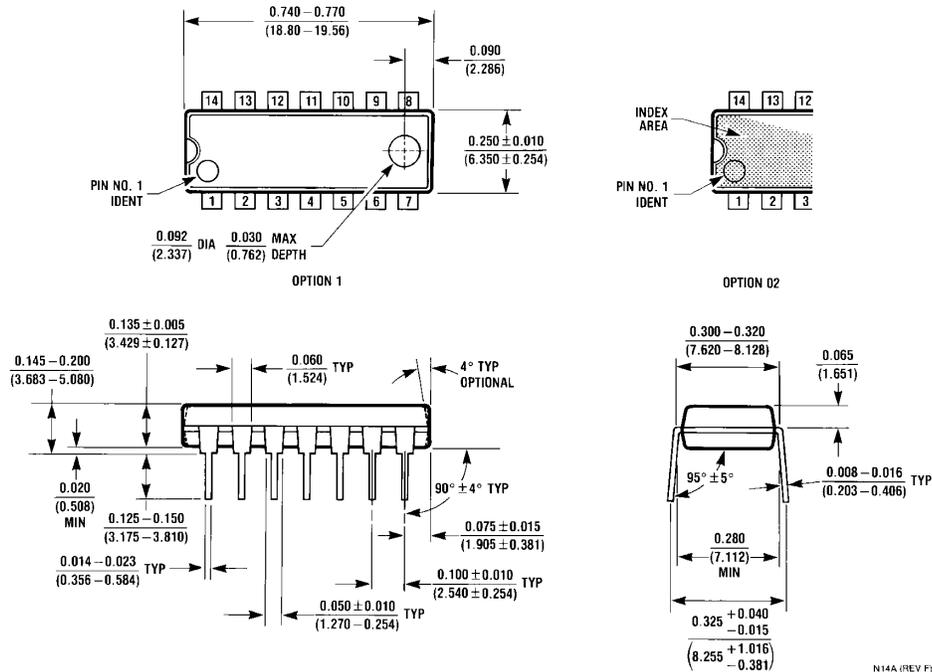
**14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
Package Number M14D**

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



**14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
Package Number MTC14**

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



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